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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

Product Status	Active
Number of LABs/CLBs	3411
Number of Logic Elements/Cells	43661
Total RAM Bits	2138112
Number of I/O	296
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	484-BBGA
Supplier Device Package	484-FBGA (23x23)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc6slx45t-2fg484i">https://www.e-xfl.com/product-detail/xilinx/xc6slx45t-2fg484i</a>

Table 2: Recommended Operating Conditions<sup>(1)</sup>

Symbol	Description			Min	Typ	Max	Units	
$V_{CCINT}$	Internal supply voltage relative to GND	-3, -3N, -2	Standard performance <sup>(2)</sup>	1.14	1.2	1.26	V	
		-3, -2	Extended performance <sup>(2)</sup>	1.2	1.23	1.26	V	
		-1L	Standard performance <sup>(2)</sup>	0.95	1.0	1.05	V	
$V_{CCAUX}^{(3)(4)}$	Auxiliary supply voltage relative to GND	$V_{CCAUX} = 2.5V^{(5)}$			2.375	2.5	2.625	V
		$V_{CCAUX} = 3.3V$			3.15	3.3	3.45	V
$V_{CCO}^{(6)(7)(8)}$	Output supply voltage relative to GND			1.1	—	3.45	V	
$V_{IN}$	Input voltage relative to GND	All I/O standards (except PCI)	Commercial temperature (C)	-0.5	—	4.0	V	
			Industrial temperature (I)	-0.5	—	3.95	V	
			Expanded (Q) temperature	-0.5	—	3.95	V	
		PCI I/O standard <sup>(9)</sup>	—	-0.5	—	$V_{CCO} + 0.5$	V	
$I_{IN}^{(10)}$	Maximum current through pin using PCI I/O standard when forward biasing the clamp diode. <sup>(9)</sup>	Commercial (C) and Industrial temperature (I)			—	—	10	mA
		Expanded (Q) temperature			—	—	7	mA
$V_{BATT}^{(11)}$	Battery voltage relative to GND, $T_j = 0^\circ\text{C}$ to $+85^\circ\text{C}$ (LX75, LX75T, LX100, LX100T, LX150, and LX150T only)			1.0	—	3.6	V	
$T_j$	Junction temperature operating range	Commercial (C) range			0	—	85	$^\circ\text{C}$
		Industrial temperature (I) range			-40	—	100	$^\circ\text{C}$
		Expanded (Q) temperature range			-40	—	125	$^\circ\text{C}$

**Notes:**

1. All voltages are relative to ground.
2. See *Interface Performances for Memory Interfaces* in Table 25. The extended performance range is specified for designs not using the standard  $V_{CCINT}$  voltage range. The standard  $V_{CCINT}$  voltage range is used for:
  - Designs that do not use an MCB
  - LX4 devices
  - Devices in the TQG144 or CPG196 packages
  - Devices with the -3N speed grade
3. Recommended maximum voltage droop for  $V_{CCAUX}$  is 10 mV/ms.
4. During configuration, if  $V_{CCO\_2}$  is 1.8V, then  $V_{CCAUX}$  must be 2.5V.
5. The -1L devices require  $V_{CCAUX} = 2.5V$  when using the LVDS\_25, LVDS\_33, BLVDS\_25, LVPECL\_25, RSDS\_25, RSDS\_33, PPDS\_25, and PPDS\_33 I/O standards on inputs. LVPECL\_33 is not supported in the -1L devices.
6. Configuration data is retained even if  $V_{CCO}$  drops to 0V.
7. Includes  $V_{CCO}$  of 1.2V, 1.5V, 1.8V, 2.5V, and 3.3V.
8. For PCI systems, the transmitter and receiver should have common supplies for  $V_{CCO}$ .
9. Devices with a -1L speed grade do not support Xilinx PCI IP.
10. Do not exceed a total of 100 mA per bank.
11.  $V_{BATT}$  is required to maintain the battery backed RAM (BBR) AES key when  $V_{CCAUX}$  is not applied. Once  $V_{CCAUX}$  is applied,  $V_{BATT}$  can be unconnected. When BBR is not used, Xilinx recommends connecting to  $V_{CCAUX}$  or GND. However,  $V_{BATT}$  can be unconnected.

## SelectIO™ Interface DC Input and Output Levels

Table 7: Recommended Operating Conditions for User I/Os Using Single-Ended Standards

I/O Standard	$V_{CCO}$ for Drivers <sup>(1)</sup>			$V_{REF}$ for Inputs		
	$V$ , Min	$V$ , Nom	$V$ , Max	$V$ , Min	$V$ , Nom	$V$ , Max
LV TTL	3.0	3.3	3.45			
LVC MOS33	3.0	3.3	3.45			
LVC MOS25	2.3	2.5	2.7			
LVC MOS18	1.65	1.8	1.95			
LVC MOS18_JEDEC	1.65	1.8	1.95			
LVC MOS15	1.4	1.5	1.6			
LVC MOS15_JEDEC	1.4	1.5	1.6			
LVC MOS12	1.1	1.2	1.3			
LVC MOS12_JEDEC	1.1	1.2	1.3			
PCI33_3 <sup>(2)</sup>	3.0	3.3	3.45			
PCI66_3 <sup>(2)</sup>	3.0	3.3	3.45			
I2C	2.7	3.0	3.45			
SMBUS	2.7	3.0	3.45			
SDIO	3.0	3.3	3.45			
MOBILE_DDR	1.7	1.8	1.9			
HSTL_I	1.4	1.5	1.6	0.68	0.75	0.9
HSTL_II	1.4	1.5	1.6	0.68	0.75	0.9
HSTL_III	1.4	1.5	1.6	–	0.9	–
HSTL_I_18	1.7	1.8	1.9	0.8	0.9	1.1
HSTL_II_18	1.7	1.8	1.9	–	0.9	–
HSTL_III_18	1.7	1.8	1.9	–	1.1	–
SSTL3_I	3.0	3.3	3.45	1.3	1.5	1.7
SSTL3_II	3.0	3.3	3.45	1.3	1.5	1.7
SSTL2_I	2.3	2.5	2.7	1.13	1.25	1.38
SSTL2_II	2.3	2.5	2.7	1.13	1.25	1.38
SSTL18_I	1.7	1.8	1.9	0.833	0.9	0.969
SSTL18_II	1.7	1.8	1.9	0.833	0.9	0.969
SSTL15_II	1.425	1.5	1.575	0.69	0.75	0.81

**Notes:**

- $V_{CCO}$  range required when using I/O standard for an output. Also required for MOBILE\_DDR, PCI33\_3, LVC MOS18\_JEDEC, LVC MOS15\_JEDEC, and LVC MOS12\_JEDEC inputs, and for LVC MOS25 inputs when  $V_{CCAUX} = 3.3V$ .
- For PCI systems, the transmitter and receiver should have common supplies for  $V_{CCO}$ .

## GTP Transceiver DC Input and Output Levels

Table 16 summarizes the DC output specifications of the GTP transceivers in Spartan-6 FPGAs. Figure 1 shows the single-ended output voltage swing. Figure 2 shows the peak-to-peak differential output voltage.

Consult [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) for further details.

Table 16: GTP Transceiver DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
DV <sub>PPIN</sub>	Differential peak-to-peak input voltage	External AC coupled	140	—	2000	mV
V <sub>IN</sub>	Absolute input voltage	DC coupled MGTAVTTRX = 1.2V	-400	—	MGTAVTTRX	mV
V <sub>CMIN</sub>	Common mode input voltage	DC coupled MGTAVTTRX = 1.2V	—	3/4 MGTAVTTRX	—	mV
DV <sub>PPOUT</sub>	Differential peak-to-peak output voltage <sup>(1)</sup>	Transmitter output swing is set to maximum setting	—	—	1000	mV
V <sub>SEOUT</sub>	Single-ended output voltage <sup>(1)</sup>	—	—	—	500	mV
V <sub>CMOUTDC</sub>	Common mode output voltage	Equation based	MGTAVTTX - V <sub>SEOUT</sub> /2			mV
R <sub>IN</sub>	Differential input resistance	—	80	100	130	Ω
R <sub>OUT</sub>	Differential output resistance	—	80	100	130	Ω
T <sub>OSKEW</sub>	Transmitter output skew	—	—	—	15	ps
C <sub>EXT</sub>	Recommended external AC coupling capacitor <sup>(2)</sup>	—	75	100	200	nF

**Notes:**

1. The output swing and preemphasis levels are programmable using the attributes discussed in [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) and can result in values lower than reported in this table.
2. Other values can be used as appropriate to conform to specific protocols and standards.

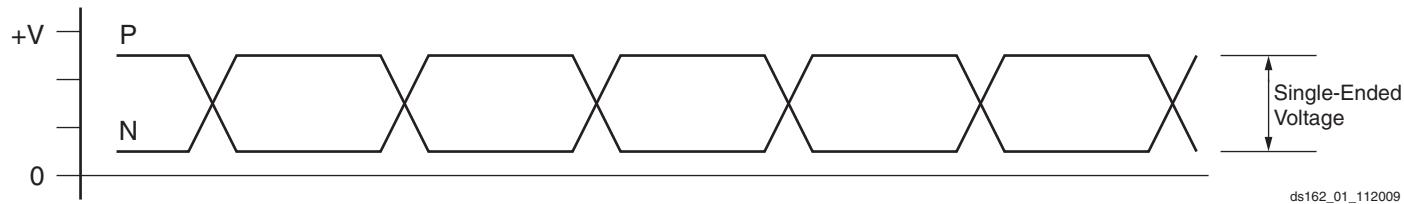


Figure 1: Single-Ended Peak-to-Peak Voltage

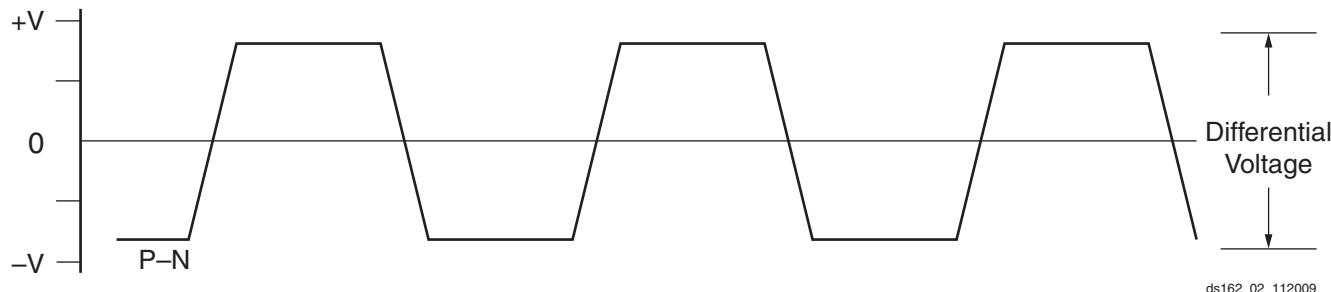


Figure 2: Differential Peak-to-Peak Voltage

Table 17 summarizes the DC specifications of the clock input of the GTP transceiver. Consult [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) for further details.

Table 21: GTP Transceiver User Clock Switching Characteristics<sup>(1)</sup>

Symbol	Description	Conditions	Speed Grade				Units
			-3	-3N	-2	-1L	
$F_{TXOUT}$	TXOUTCLK maximum frequency		320	320	270	N/A	MHz
$F_{RXREC}$	RXRECCCLK maximum frequency		320	320	270	N/A	MHz
$T_{RX}$	RXUSRCLK maximum frequency		320	320	270	N/A	MHz
$T_{RX2}$	RXUSRCLK2 maximum frequency	1 byte interface	156.25	156.25	125	N/A	MHz
		2 byte interface	160	160	125	N/A	MHz
		4 byte interface	80	80	67.5	N/A	MHz
$T_{TX}$	TXUSRCLK maximum frequency		320	320	270	N/A	MHz
$T_{TX2}$	TXUSRCLK2 maximum frequency	1 byte interface	156.25	156.25	125	N/A	MHz
		2 byte interface	160	160	125	N/A	MHz
		4 byte interface	80	80	67.5	N/A	MHz

## Notes:

1. Clocking must be implemented as described in [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#).

Table 22: GTP Transceiver Transmitter Switching Characteristics

Symbol	Description	Condition	Min	Typ	Max	Units
$T_{RTX}$	TX Rise time	20%–80%	—	140	—	ps
$T_{FTX}$	TX Fall time	80%–20%	—	120	—	ps
$T_{LLSKEW}$	TX lane-to-lane skew <sup>(1)</sup>		—	—	400	ps
$V_{TXOOBVDP}$	Electrical idle amplitude		—	—	20	mV
$T_{TXOOBTTRANSITION}$	Electrical idle transition time		—	—	50	ns
$T_{J3.125}$	Total Jitter <sup>(2)</sup>	3.125 Gb/s	—	—	0.35	UI
$D_{J3.125}$	Deterministic Jitter <sup>(2)</sup>		—	—	0.15	UI
$T_{J2.5}$	Total Jitter <sup>(2)</sup>	2.5 Gb/s	—	—	0.33	UI
$D_{J2.5}$	Deterministic Jitter <sup>(2)</sup>		—	—	0.15	UI
$T_{J1.62}$	Total Jitter <sup>(2)</sup>	1.62 Gb/s	—	—	0.20	UI
$D_{J1.62}$	Deterministic Jitter <sup>(2)</sup>		—	—	0.10	UI
$T_{J1.25}$	Total Jitter <sup>(2)</sup>	1.25 Gb/s	—	—	0.20	UI
$D_{J1.25}$	Deterministic Jitter <sup>(2)</sup>		—	—	0.10	UI
$T_{J614}$	Total Jitter <sup>(2)</sup>	614 Mb/s	—	—	0.10	UI
$D_{J614}$	Deterministic Jitter <sup>(2)</sup>		—	—	0.05	UI

## Notes:

1. Using same REFCLK input with TXENPMAPHASEALIGN enabled for up to four consecutive GTP transceiver sites.  
 2. Using PLL\_DIVSEL\_FB = 2, INTDATAWIDTH = 1. These values are NOT intended for protocol specific compliance determinations.

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Spartan-6 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [Switching Characteristics, page 19](#).

**Table 25: Interface Performances**

<b>Description</b>	<b>I/O Resource</b>	<b>Clock Buffer</b>	<b>Data Width</b>	<b>Speed Grade</b>				<b>Units</b>		
				<b>-3</b>	<b>-3N</b>	<b>-2</b>	<b>-1L</b>			
<b>Networking Applications<sup>(1)</sup></b>										
SDR LVDS transmitter or receiver	IOB SDR register	BUFG	—	400	400	375	250	Mb/s		
DDR LVDS transmitter or receiver	ODDR2/IDDR2 register	2 BUFGs	—	800	800	750	500	Mb/s		
SDR LVDS transmitter	OSERDES2	BUFPLL	2	500	500	500	250	Mb/s		
			3	750	750	750	375	Mb/s		
			4-8	1080	1050	950	500	Mb/s		
DDR LVDS transmitter	OSERDES2	2 BUFIO2s	2	500	500	500	250	Mb/s		
			3	750	750	750	375	Mb/s		
			4-8	1080	1050	950	500	Mb/s		
SDR LVDS receiver	ISERDES2 in RETIMED mode	BUFPLL	2	500	500	500	—	Mb/s		
			3	750	750	750	—	Mb/s		
			4-8	1080	1050	950	—	Mb/s		
DDR LVDS receiver	ISERDES2 in RETIMED mode	2 BUFIO2s	2	500	500	500	—	Mb/s		
			3	750	750	750	—	Mb/s		
			4-8	1080	1050	950	—	Mb/s		
<b>Memory Interfaces (Implemented using the Spartan-6 FPGA Memory Controller Block)<sup>(2)</sup></b>										
<b>Standard Performance (Standard V<sub>CCINT</sub>)</b>										
DDR				400	<a href="#">Note 4</a>	400	350	Mb/s		
DDR2				667	<a href="#">Note 4</a>	625	400	Mb/s		
DDR3				800	<a href="#">Note 4</a>	667	—	Mb/s		
LPDDR (Mobile_DDR)				400	<a href="#">Note 4</a>	400	350	Mb/s		
<b>Extended Performance (Requires Extended Performance V<sub>CCINT</sub>)<sup>(3)</sup></b>										
DDR2				800	<a href="#">Note 4</a>	667	—	Mb/s		

**Notes:**

- Refer to [XAPP1064](#), *Source-Synchronous Serialization and Deserialization (up to 1050 Mb/s)* and [UG381](#), *Spartan-6 FPGA SelectIO Resources User Guide*.
- Refer to [UG388](#), *Spartan-6 FPGA Memory Controller User Guide*.
- Extended Memory Controller block performance for DDR2 can be achieved using the extended performance V<sub>CCINT</sub> range from [Table 2](#).
- The LX4 device, all devices in the TQG144 and CPG196 packages, and the -3N speed grade do not support a Memory Controller Block.

Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices<sup>(1)</sup>

I/O Standard	T <sub>IOP1</sub>		T <sub>IOP0</sub>		T <sub>IOTP</sub>		Units	
	Speed Grade		Speed Grade		Speed Grade			
	-3	-2	-3	-2	-3	-2		
LVDS_33	1.24	1.42	1.69	1.89	3000	3000	ns	
LVDS_25	1.08	1.26	1.79	1.99	3000	3000	ns	
BLVDS_25	1.09	1.27	1.86	2.06	1.86	2.06	ns	
MINI_LVDS_33	1.25	1.43	1.71	1.91	3000	3000	ns	
MINI_LVDS_25	1.08	1.26	1.79	1.99	3000	3000	ns	
LVPECL_33	1.25	1.43	N/A	N/A	N/A	N/A	ns	
LVPECL_25	1.09	1.27	N/A	N/A	N/A	N/A	ns	
RSDS_33 (point to point)	1.24	1.42	1.71	1.91	3000	3000	ns	
RSDS_25 (point to point)	1.08	1.26	1.79	1.99	3000	3000	ns	
TMDS_33	1.29	1.47	1.68	1.88	3000	3000	ns	
PPDS_33	1.25	1.43	1.71	1.91	3000	3000	ns	
PPDS_25	1.08	1.26	1.82	2.02	3000	3000	ns	
PCI33_3	1.14	1.32	3.81	4.01	3.81	4.01	ns	
PCI66_3	1.14	1.32	3.81	4.01	3.81	4.01	ns	
DISPLAY_PORT	1.09	1.27	3.29	3.49	3.29	3.49	ns	
I2C	1.40	1.58	11.70	11.90	11.70	11.90	ns	
SMBUS	1.40	1.58	11.70	11.90	11.70	11.90	ns	
SDIO	1.43	1.61	2.78	2.98	2.78	2.98	ns	
MOBILE_DDR	1.01	1.19	2.50	2.70	2.50	2.70	ns	
HSTL_I	1.01	1.19	1.80	2.00	1.80	2.00	ns	
HSTL_II	1.01	1.19	1.86	2.06	1.86	2.06	ns	
HSTL_III	1.07	1.25	1.81	2.01	1.81	2.01	ns	
HSTL_I_18	1.05	1.23	1.91	2.11	1.91	2.11	ns	
HSTL_II_18	1.05	1.23	1.99	2.19	1.99	2.19	ns	
HSTL_III_18	1.13	1.31	1.93	2.13	1.93	2.13	ns	
SSTL3_I	1.65	1.83	1.97	2.17	1.97	2.17	ns	
SSTL3_II	1.65	1.83	2.15	2.35	2.15	2.35	ns	
SSTL2_I	1.37	1.55	1.91	2.11	1.91	2.11	ns	
SSTL2_II	1.37	1.55	2.00	2.20	2.00	2.20	ns	
SSTL18_I	0.99	1.17	1.77	1.97	1.77	1.97	ns	
SSTL18_II	1.00	1.18	1.80	2.00	1.80	2.00	ns	
SSTL15_II	1.00	1.18	1.81	2.01	1.81	2.01	ns	
DIFF_HSTL_I	1.01	1.19	1.91	2.11	1.91	2.11	ns	
DIFF_HSTL_II	1.00	1.18	1.86	2.06	1.86	2.06	ns	
DIFF_HSTL_III	1.00	1.18	1.83	2.03	1.83	2.03	ns	
DIFF_HSTL_I_18	1.04	1.22	1.93	2.13	1.93	2.13	ns	
DIFF_HSTL_II_18	1.04	1.22	1.83	2.03	1.83	2.03	ns	
DIFF_HSTL_III_18	1.04	1.22	1.83	2.03	1.83	2.03	ns	

Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices<sup>(1)</sup> (Cont'd)

I/O Standard	T <sub>IOP1</sub>		T <sub>IOOP</sub>		T <sub>IOTP</sub>		Units	
	Speed Grade		Speed Grade		Speed Grade			
	-3	-2	-3	-2	-3	-2		
LVCMOS33, Slow, 6 mA	1.41	1.59	2.79	2.99	2.79	2.99	ns	
LVCMOS33, Slow, 8 mA	1.41	1.59	2.79	2.99	2.79	2.99	ns	
LVCMOS33, Slow, 12 mA	1.41	1.59	2.53	2.73	2.53	2.73	ns	
LVCMOS33, Slow, 16 mA	1.41	1.59	2.45	2.65	2.45	2.65	ns	
LVCMOS33, Slow, 24 mA	1.41	1.59	2.42	2.62	2.42	2.62	ns	
LVCMOS33, Fast, 2 mA	1.41	1.59	4.05	4.25	4.05	4.25	ns	
LVCMOS33, Fast, 4 mA	1.41	1.59	2.66	2.86	2.66	2.86	ns	
LVCMOS33, Fast, 6 mA	1.41	1.59	2.46	2.66	2.46	2.66	ns	
LVCMOS33, Fast, 8 mA	1.41	1.59	2.21	2.41	2.21	2.41	ns	
LVCMOS33, Fast, 12 mA	1.41	1.59	1.80	2.00	1.80	2.00	ns	
LVCMOS33, Fast, 16 mA	1.41	1.59	1.80	2.00	1.80	2.00	ns	
LVCMOS33, Fast, 24 mA	1.41	1.59	1.80	2.00	1.80	2.00	ns	
LVCMOS25, QUIETIO, 2 mA	0.89	1.07	5.00	5.20	5.00	5.20	ns	
LVCMOS25, QUIETIO, 4 mA	0.89	1.07	3.85	4.05	3.85	4.05	ns	
LVCMOS25, QUIETIO, 6 mA	0.89	1.07	3.60	3.80	3.60	3.80	ns	
LVCMOS25, QUIETIO, 8 mA	0.89	1.07	3.34	3.54	3.34	3.54	ns	
LVCMOS25, QUIETIO, 12 mA	0.89	1.07	2.98	3.18	2.98	3.18	ns	
LVCMOS25, QUIETIO, 16 mA	0.89	1.07	2.79	2.99	2.79	2.99	ns	
LVCMOS25, QUIETIO, 24 mA	0.89	1.07	2.64	2.84	2.64	2.84	ns	
LVCMOS25, Slow, 2 mA	0.89	1.07	3.96	4.16	3.96	4.16	ns	
LVCMOS25, Slow, 4 mA	0.89	1.07	2.96	3.16	2.96	3.16	ns	
LVCMOS25, Slow, 6 mA	0.89	1.07	2.88	3.08	2.88	3.08	ns	
LVCMOS25, Slow, 8 mA	0.89	1.07	2.63	2.83	2.63	2.83	ns	
LVCMOS25, Slow, 12 mA	0.89	1.07	2.15	2.35	2.15	2.35	ns	
LVCMOS25, Slow, 16 mA	0.89	1.07	2.15	2.35	2.15	2.35	ns	
LVCMOS25, Slow, 24 mA	0.89	1.07	2.15	2.35	2.15	2.35	ns	
LVCMOS25, Fast, 2 mA	0.89	1.07	3.52	3.72	3.52	3.72	ns	
LVCMOS25, Fast, 4 mA	0.89	1.07	2.43	2.63	2.43	2.63	ns	
LVCMOS25, Fast, 6 mA	0.89	1.07	2.23	2.43	2.23	2.43	ns	
LVCMOS25, Fast, 8 mA	0.89	1.07	2.16	2.36	2.16	2.36	ns	
LVCMOS25, Fast, 12 mA	0.89	1.07	1.70	1.90	1.70	1.90	ns	
LVCMOS25, Fast, 16 mA	0.89	1.07	1.70	1.90	1.70	1.90	ns	
LVCMOS25, Fast, 24 mA	0.89	1.07	1.70	1.90	1.70	1.90	ns	
LVCMOS18, QUIETIO, 2 mA	1.25	1.43	6.11	6.31	6.11	6.31	ns	
LVCMOS18, QUIETIO, 4 mA	1.25	1.43	4.88	5.08	4.88	5.08	ns	
LVCMOS18, QUIETIO, 6 mA	1.25	1.43	4.20	4.40	4.20	4.40	ns	
LVCMOS18, QUIETIO, 8 mA	1.25	1.43	3.86	4.06	3.86	4.06	ns	
LVCMOS18, QUIETIO, 12 mA	1.25	1.43	3.49	3.69	3.49	3.69	ns	

Table 32: Output Delay Measurement Methodology (Cont'd)

Description	I/O Standard Attribute	R <sub>REF</sub> (Ω)	C <sub>REF</sub> <sup>(1)</sup> (pF)	V <sub>MEAS</sub> (V)	V <sub>REF</sub> (V)
SSTL, Class II, 2.5V	SSTL2_II	25	0	V <sub>REF</sub>	1.25
SSTL, Class II, 1.5V	SSTL15_II	25	0	V <sub>REF</sub>	0.75
LVDS (Low-Voltage Differential Signaling), 2.5V & 3.3V	LVDS_25, LVDS_33	100	0	0 <sup>(3)</sup>	—
BLVDS (Bus LVDS), 2.5V	BLVDS_25	Note 4	0	0 <sup>(3)</sup>	—
Mini-LVDS, 2.5V & 3.3V	MINI_LVDS_25, MINI_LVDS_33	100	0	0 <sup>(3)</sup>	—
RSDS (Reduced Swing Differential Signaling), 2.5V & 3.3V	RSDS_25, RSDS_33	100	0	0 <sup>(3)</sup>	—
TMDS (Transition Minimized Differential Signaling), 3.3V	TMDS_33	Note 5	0	0 <sup>(3)</sup>	—
PPDS (Point-to-Point Differential Signaling, 2.5V & 3.3V	PPDS_25, PPDS_33	100	0	0 <sup>(3)</sup>	—

**Notes:**

1. C<sub>REF</sub> is the capacitance of the probe, nominally 0 pF.
2. Per PCI specifications.
3. The value given is the differential output voltage.
4. See the *BLVDS Output Termination* section in [UG381, Spartan-6 FPGA SelectIO Resources User Guide](#).
5. See the *TMDS\_33 Termination* section in [UG381, Spartan-6 FPGA SelectIO Resources User Guide](#).

## Simultaneously Switching Outputs

Due to package electrical parasitics, a given package supports a limited number of simultaneous switching outputs (SSOs) when using fast, high-drive outputs. [Table 33](#) and [Table 34](#) provide guidelines for the recommended maximum allowable number of SSOs. These guidelines describe the maximum number of user I/O pins of an output signal standard that should simultaneously switch in the same direction, while maintaining a safe level of switching noise for that particular signal standard. Meeting these guidelines for the stated test conditions ensures that the FPGA operates free from the adverse effects of GND and power bounce.

For each device/package combination, [Table 33](#) provides the number of equivalent V<sub>CCO</sub>/GND pairs per bank. For each output signal standard and drive strength, [Table 34](#) recommends the maximum number of SSOs, switching in the same direction, allowed per V<sub>CCO</sub>/GND pair within an I/O bank. The guidelines are categorized by package style, slew rate, and output drive current. The number of SSOs are also specified by I/O bank. Multiply the appropriate numbers from each table to calculate the maximum number of SSOs allowed within an I/O bank. The guidelines assume that all pins within a bank use the same I/O standard. Exceeding these SSO guidelines can result in increased power or GND bounce, degraded signal integrity, or increased system jitter. For a given I/O standard, if the SSO limit per pair in [Table 34](#) is greater than the maximum I/O per pair in [Table 33](#), then there is no SSO limit for the exclusive use of that I/O standard.

The recommended maximum SSO values assume that the FPGA is soldered on a printed circuit board and that the board uses sound design practices. Due to the additional inductance introduced by the socket, the SSO values do not apply for FPGAs mounted in sockets. The SSO values assume that the V<sub>CCAUX</sub> is powered at 3.3V. Setting V<sub>CCAUX</sub> to 2.5V provides better SSO characteristics. For more detail, see [UG381: Spartan-6 FPGA SelectIO Resources User Guide](#).

Table 34: SSO Limit per V<sub>CCO</sub>/GND Pair (Cont'd)

V <sub>CCO</sub>	I/O Standard	Drive	Slew	SSO Limit per V <sub>CCO</sub> /GND Pair					
				All TQG144, CPG196, CSG225, FT(G)256, and LX devices in CSG324		All CS(G)484, FG(G)484, FG(G)676, FG(G)900, and LXT devices in CSG324			
				Bank 0/2	Bank 1/3	Bank 0/2	Bank 1/3/4/5		
2.5V	LVCMS25	2	Fast	38	43	38	43		
			Slow	46	52	46	48		
			QuietIO	57	64	57	59		
		4	Fast	21	24	21	23		
			Slow	26	31	26	27		
			QuietIO	33	32	33	30		
		6	Fast	15	17	15	16		
			Slow	19	22	19	19		
			QuietIO	25	23	25	19		
		8	Fast	12	15	12	14		
			Slow	15	18	15	16		
			QuietIO	21	19	21	16		
		12	Fast	1	3	1	1		
			Slow	2	7	2	4		
			QuietIO	3	8	3	8		
		16	Fast	1	3	1	1		
			Slow	3	7	3	3		
			QuietIO	4	9	4	8		
		24	Fast	N/A	3	N/A	1		
			Slow	N/A	5	N/A	2		
			QuietIO	N/A	8	N/A	6		
SSTL_2_I <sup>(3)</sup>				10	11	10	11		
SSTL_2_II <sup>(3)</sup>				N/A	7	N/A	7		
DIFF_SSTL_2_I <sup>(3)</sup>				30	33	30	33		
DIFF_SSTL_2_II <sup>(3)</sup>				N/A	21	N/A	24		

## Input/Output Logic Switching Characteristics

Table 35: ILOGIC2 Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Setup/Hold</b>						
T <sub>ICE0CK</sub> /T <sub>ICKCE0</sub>	CE0 pin Setup/Hold with respect to CLK	0.56/ -0.30	0.56/ -0.25	0.79/ -0.22	1.21/ -0.52	ns
T <sub>ISRCK</sub> /T <sub>ICKSR</sub>	SR pin Setup/Hold with respect to CLK	0.74/ -0.23	0.74/ -0.22	0.98/ -0.20	1.31/ -0.45	ns
T <sub>IDOCK</sub> /T <sub>IOCKD</sub>	D pin Setup/Hold with respect to CLK without Delay	1.19/ -0.83	1.36/ -0.83	1.73/ -0.83	2.18/ -1.77	ns
T <sub>IDOCKD</sub> /T <sub>IOCKDD</sub>	DDLY pin Setup/Hold with respect to CLK (using IODELAY2)	0.31/ 0.00	0.47/ 0.00	0.54/ 0.00	0.63/ -0.39	ns
<b>Combinatorial</b>						
T <sub>IDI</sub>	D pin to O pin propagation delay, no Delay	0.95	1.28	1.53	2.25	ns
T <sub>IDID</sub>	DDLY pin to O pin propagation delay (using IODELAY2)	0.23	0.39	0.44	0.74	ns
<b>Sequential Delays</b>						
T <sub>IDLO</sub>	D pin to Q pin using flip-flop as a latch without Delay	1.56	1.86	2.39	3.49	ns
T <sub>IDLOD</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IODELAY2)	0.68	0.97	1.20	1.94	ns
T <sub>ICKQ</sub>	CLK to Q outputs for XC devices	1.03	1.24	1.43	2.11	ns
	CLK to Q outputs for XA and XQ devices	1.38	N/A	1.78	2.11	ns
T <sub>TRQ_ILOGIC2</sub>	SR pin to Q outputs	1.81	1.81	2.50	3.05	ns

Table 36: OLOGIC2 Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Setup/Hold</b>						
T <sub>ODCK</sub> /T <sub>OCKD</sub>	D1/D2 pins Setup/Hold with respect to CLK	0.81/ -0.05	0.86/ -0.05	1.18/ 0.00	1.73/ -0.27	ns
T <sub>OOC ECK</sub> /T <sub>OCKOCE</sub>	OCE pin Setup/Hold with respect to CLK	0.75/ -0.10	0.75/ -0.10	1.01/ -0.05	1.66/ -0.23	ns
T <sub>OSRCK</sub> /T <sub>OCKSR</sub>	SR pin Setup/Hold with respect to CLK	0.70/ -0.28	0.79/ -0.28	1.03/ -0.23	1.39/ -0.47	ns
T <sub>OTCK</sub> /T <sub>OCKT</sub>	T1/T2 pins Setup/Hold with respect to CLK	0.24/ -0.08	0.56/ -0.06	0.83/ -0.01	0.99/ -0.19	ns
T <sub>OTCECK</sub> /T <sub>OCKTCE</sub>	TCE pin Setup/Hold with respect to CLK	0.58/ -0.06	0.72/ -0.06	1.18/ -0.01	1.51/ -0.13	ns
<b>Sequential Delays</b>						
T <sub>OCKQ</sub>	CLK to OQ/TQ out for XC devices	0.48	0.51	0.74	0.74	ns
	CLK to OQ/TQ out for XA and XQ devices	0.85	N/A	1.16	0.74	ns
T <sub>TRQ_OLOGIC2</sub>	SR pin to OQ/TQ out	1.81	1.81	2.50	3.05	ns

## CLB Distributed RAM Switching Characteristics (SLICEM Only)

Table 41: CLB Distributed RAM Switching Characteristics (SLICEM Only)

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Sequential Delays</b>						
T <sub>SHCKO</sub>	Clock to A – D outputs	1.26	1.55	1.55	2.35	ns, Max
	Clock to A – D outputs (direct output path)	0.96	1.20	1.20	1.87	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>DS</sub> /T <sub>DH</sub>	AX – DX or AI – DI inputs to CLK	0.59/ 0.17	0.73/ 0.22	0.73/ 0.22	1.17/ 0.33	ns, Min
T <sub>AS</sub> /T <sub>AH</sub>	Address An inputs to clock for XC devices	0.28/ 0.35	0.32/ 0.42	0.32/ 0.42	0.26/ 0.71	ns, Min
	Address An inputs to clock for XA and XQ devices	0.28/ 0.51	N/A	0.32/ 0.51	0.26/ 0.71	ns, Min
T <sub>WS</sub> /T <sub>WH</sub>	WE input to clock	0.31/ –0.08	0.37/ –0.08	0.37/ –0.08	0.59/ –0.27	ns, Min
T <sub>CECK</sub> /T <sub>CKCE</sub>	CE input to CLK	0.31/ –0.08	0.37/ –0.08	0.37/ –0.08	0.59/ –0.27	ns, Min

## CLB Shift Register Switching Characteristics (SLICEM Only)

Table 42: CLB Shift Register Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Sequential Delays</b>						
T <sub>REG</sub>	Clock to A – D outputs	1.35	1.78	1.78	2.74	ns, Max
	Clock to A – D outputs (direct output path)	1.24	1.65	1.65	2.48	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>WS</sub> /T <sub>WH</sub>	WE input to CLK	0.20/ –0.07	0.24/ –0.07	0.24/ –0.07	0.29/ –0.27	ns, Min
T <sub>CECK</sub> /T <sub>CKCE</sub>	CE input to CLK for XC devices	0.30/ 0.30	0.30/ 0.38	0.30/ 0.38	0.82/ –0.41	ns, Min
	CE input to CLK for XA and XQ devices	0.32/ 0.30	N/A	0.40/ 0.38	0.82/ –0.41	ns, Min
T <sub>DS</sub> /T <sub>DH</sub>	AX – DX or AI – DI inputs to CLK	0.07/ 0.11	0.09/ 0.14	0.09/ 0.14	0.11/ 0.23	ns, Min

Table 47: Configuration Switching Characteristics<sup>(1)</sup> (Cont'd)

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>BPI Master Flash Mode Programming Switching<sup>(4)</sup></b>						
T <sub>BPICCO</sub> <sup>(5)</sup>	A[25:0], FCS_B, FOE_B, FWE_B, LDC outputs valid after CCLK falling edge	15	15	15	20	ns, Max
T <sub>BPIICCK</sub>	Master BPI CCLK (output) delay	10/100	10/100	10/100	10/130	μs, Min/Max
T <sub>BPIDCC</sub> /T <sub>BPICCD</sub>	Setup/Hold on D[15:0] data input pins	5.0/1.0	5.0/1.0	5.0/1.0	6.0/2.0	ns, Min
<b>SPI Master Flash Mode Programming Switching<sup>(6)</sup></b>						
T <sub>SPIDCC</sub> /T <sub>SPIDCCD</sub>	DIN, MISO0, MISO1, MISO2, MISO3, Setup/Hold before/after the rising CCLK edge	5.0/1.0	5.0/1.0	5.0/1.0	7.0/1.0	ns, Min
T <sub>SPIIICCK</sub>	Master SPI CCLK (output) delay	0.4/7.0	0.4/7.0	0.4/7.0	0.4/10.0	μs, Min/Max
T <sub>SPICCM</sub>	MOSI clock to out	13	13	13	19	ns, Max
T <sub>SPICCF</sub>	CSO_B clock to out	16	16	16	26	ns, Max
<b>CCLK Output (Master Modes)</b>						
T <sub>MCCKL</sub>	Master CCLK clock duty cycle Low	40/60				%, Min/Max
T <sub>MCCKH</sub>	Master CCLK clock duty cycle High	40/60				%, Min/Max
F <sub>MCC</sub>	Maximum frequency, serial mode (Master Serial/SPI) All devices	40	40	40	30	MHz, Max
	Maximum frequency, parallel mode (Master SelectMAP/BPI) LX9, LX16, LX25, LX25T, LX45, LX45T, LX75, and LX75T	40	40	40	25	MHz, Max
	Maximum frequency, parallel mode (Master SelectMAP/BPI) LX100 and LX100T in x8 mode, LX150, and LX150T	40	40	40	20	MHz, Max
	Maximum frequency, parallel mode (Master SelectMAP/BPI) LX100 and LX100T in x16 mode	35	35	35	20	MHz, Max
F <sub>MCCKTOL</sub>	Frequency Tolerance, master mode	±50	±50	±50	±50	%
<b>CCLK Input (Slave Modes)</b>						
T <sub>SCCKL</sub>	Slave CCLK clock minimum Low time	5	5	5	8	ns, Min
T <sub>SCCKH</sub>	Slave CCLK clock minimum High time	5	5	5	8	ns, Min
<b>USERCCLK Input</b>						
T <sub>USERCCLKL</sub>	USERCCLK clock minimum Low time	12	12	12	16	ns, Min
T <sub>USERCCLKH</sub>	USERCCLK clock minimum High time	12	12	12	16	ns, Min
F <sub>USERCCLK</sub>	Maximum USERCCLK frequency	40	40	40	30	MHz, Max

**Notes:**

1. Maximum frequency and setup/hold timing parameters are for 3.3V and 2.5V configuration voltages.
2. To support longer delays in configuration, use the design solutions described in [UG380: Spartan-6 FPGA Configuration User Guide](#).
3. [Table 6](#) specifies the power supply ramp time.
4. BPI mode is not supported in:
  - LX4, LX25, or LX25T devices
  - LX9 devices in the TQG144 package
  - LX9 or LX16 devices in the CPG196 package.
5. Only during configuration, the last edge is determined by a weak pull-up/pull-down resistor in the I/O.
6. Defense-grade Spartan-6Q -2Q devices configure in single default SPI Master (x1) mode at  $T_j = -55^{\circ}\text{C}$ . During operation and when using all other configuration functions, the minimum operating temperature is  $-40^{\circ}\text{C}$ .

## Clock Buffers and Networks

Table 48: Global Clock Switching Characteristics (BUFGMUX)

Symbol	Description	Devices	Speed Grade				Units
			-3	-3N	-2	-1L	
$T_{GSI}$	S pin Setup to I0/I1 inputs	LX devices	0.25	0.31	0.48	0.48	ns
		LXT devices	0.25	0.31	0.48	N/A	ns
$T_{GIO}$	BUFGMUX delay from I0/I1 to O	LX devices	0.21	0.21	0.21	0.21	ns
		LXT devices	0.21	0.21	0.21	N/A	ns
<b>Maximum Frequency</b>							
$F_{MAX}$	Global clock tree (BUFGMUX)	LX devices	400	400	375	250	MHz
		LXT devices	400	400	375	N/A	MHz

Table 49: Input/Output Clock Switching Characteristics (BUFIO2)

Symbol	Description	Devices	Speed Grade				Units
			-3	-3N	-2	-1L	
$T_{BUFCKO\_O}$	Clock to out delay from I to O	LX devices	0.67	0.82	1.09	1.50	ns
		LXT devices	0.67	0.82	1.09	N/A	ns
<b>Maximum Frequency</b>							
$F_{MAX}$	I/O clock tree (BUFIO2)	LX devices	540	525	500	300	MHz
		LXT devices	540	525	500	N/A	MHz

Table 50: Input/Output Clock Switching Characteristics (BUFIO2FB)

Symbol	Description	Devices	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Maximum Frequency</b>							
$F_{MAX}$	I/O clock tree (BUFIO2FB)	LX devices	1080	1050	950	500	MHz
		LXT devices	1080	1050	950	N/A	MHz

Table 51: Input/Output Clock Switching Characteristics (BUFPLL)

Symbol	Description	Devices	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Maximum Frequency</b>							
$F_{MAX}$	BUFPLL clock tree (BUFPLL)	LX devices	1080	1050	950	500	MHz
		LXT devices	1080	1050	950	N/A	MHz

## PLL Switching Characteristics

Table 52: PLL Specification

Symbol	Description	Device(1)	Speed Grade				Units
			-3	-3N	-2	-1L	
$F_{INMAX}$	Maximum Input Clock Frequency from I/O Clock	LX devices	540	525	450	300	MHz
		LXT devices	540	525	450	N/A	MHz
	Maximum Input Clock Frequency from Global Clock	LX devices	400	400	375	250	MHz
		LXT devices	400	400	375	N/A	MHz

Table 52: PLL Specification (Cont'd)

Symbol	Description	Device <sup>(1)</sup>	Speed Grade				Units
			-3	-3N	-2	-1L	
$F_{INMIN}$	Minimum Input Clock Frequency	LX devices	19	19	19	19	MHz
		LXT devices	19	19	19	N/A	MHz
$F_{INJITTER}$	Maximum Input Clock Period Jitter: 19–200 MHz	All	1 ns Maximum				
	Maximum Input Clock Period Jitter: > 200 MHz	All	<20% of clock input period Maximum				
$F_{INDUTY}$	Allowable Input Duty Cycle: 19—199 MHz	All	25/75				%
	Allowable Input Duty Cycle: 200—299 MHz	All	35/65				%
	Allowable Input Duty Cycle: > 300 MHz	All	45/55				%
$F_{VCOMIN}$	Minimum PLL VCO Frequency	LX devices	400	400	400	400	MHz
		LXT devices	400	400	400	N/A	MHz
$F_{VCOMAX}$	Maximum PLL VCO Frequency	LX devices	1080	1050	1000	1000	MHz
		LXT devices	1080	1050	1000	N/A	MHz
$F_{BANDWIDTH}$	Low PLL Bandwidth at Typical <sup>(3)</sup>	All	1	1	1	1	MHz
	High PLL Bandwidth at Typical <sup>(3)</sup>	All	4	4	4	4	MHz
$T_{STAPHAOFFSET}$	Static Phase Offset of the PLL Outputs	All	0.12	0.12	0.12	0.15	ns
$T_{OUTJITTER}$	PLL Output Jitter <sup>(3)</sup>	All	Note 2				
$T_{OUTDUTY}$	PLL Output Clock Duty Cycle Precision <sup>(4)</sup>	All	0.15	0.15	0.20	0.25	ns
$T_{LOCKMAX}$	PLL Maximum Lock Time	All	100	100	100	100	μs
$F_{OUTMAX}$	PLL Maximum Output Frequency for BUFGMUX	LX devices	400	400	375	250	MHz
		LXT devices	400	400	375	N/A	MHz
	PLL Maximum Output Frequency for BUFPLL	LX devices	1080	1050	950	500	MHz
		LXT devices	1080	1050	950	N/A	MHz
$F_{OUTMIN}$	PLL Minimum Output Frequency <sup>(5)</sup>	All	3.125	3.125	3.125	3.125	MHz
$T_{EXTFDVAR}$	External Clock Feedback Variation: 19–200 MHz	All	1 ns Maximum				
	External Clock Feedback Variation: > 200 MHz	All	< 20% of clock input period Maximum				
$RST_{MINPULSE}$	Minimum Reset Pulse Width	All	5	5	5	5	ns
$F_{PFDMAX}^{(5)}$	Maximum Frequency at the Phase Frequency Detector	LX devices	500	500	400	300	MHz
		LXT devices	500	500	400	N/A	MHz
$F_{PFDMIN}$	Minimum Frequency at the Phase Frequency Detector	LX devices	19	19	19	19	MHz
		LXT devices	19	19	19	N/A	MHz
$T_{FBDELAY}$	Maximum Delay in the Feedback Path	All	3 ns Max or one CLKIN cycle				

**Notes:**

1. LXT devices are not available with a -1L speed grade.
2. Values for this parameter are available in the Clocking Wizard.
3. The PLL does not filter typical spread spectrum input clocks because they are usually far below the bandwidth filter frequencies.
4. Includes global clock buffer.
5. Calculated as  $F_{VCO}/128$  assuming output duty cycle is 50%.
6. When using CLK\_FEEDBACK = CLKOUT0 with BUFI02 feedback, the feedback frequency will be higher than the phase frequency detector frequency.  $F_{PFDMAX} = F_{CLKFB} / CLKFBOUT_MULT$

Table 66: Global Clock Input to Output Delay With PLL in System-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
LVCMOS25 Global Clock Input to Output Delay using Output Flip-Flop, 12mA, Fast Slew Rate, <i>with</i> PLL in System-Synchronous Mode.							
T <sub>CLOCKPLL</sub>	Global Clock and OUTFF <i>with</i> PLL	XC6SLX4	4.57	N/A	6.25	7.34	ns
		XC6SLX9	4.57	5.25	6.25	7.34	ns
		XC6SLX16	4.41	4.64	5.39	6.92	ns
		XC6SLX25	4.03	4.32	4.91	7.64	ns
		XC6SLX25T	4.03	4.32	4.91	N/A	ns
		XC6SLX45	4.63	4.96	5.75	7.36	ns
		XC6SLX45T	4.63	4.96	5.75	N/A	ns
		XC6SLX75	4.01	4.30	4.88	7.15	ns
		XC6SLX75T	4.01	4.30	4.88	N/A	ns
		XC6SLX100	4.02	4.33	4.90	7.37	ns
		XC6SLX100T	4.06	4.33	4.90	N/A	ns
		XC6SLX150	3.65	3.98	4.58	6.94	ns
		XC6SLX150T	3.65	3.98	4.58	N/A	ns
		XA6SLX4	4.88	N/A	6.13	N/A	ns
		XA6SLX9	4.88	N/A	6.13	N/A	ns
		XA6SLX16	4.74	N/A	5.27	N/A	ns
		XA6SLX25	4.43	N/A	4.78	N/A	ns
		XA6SLX25T	4.43	N/A	4.88	N/A	ns
		XA6SLX45	4.94	N/A	5.62	N/A	ns
		XA6SLX45T	4.94	N/A	5.62	N/A	ns
		XA6SLX75	4.32	N/A	4.77	N/A	ns
		XA6SLX75T	4.32	N/A	4.77	N/A	ns
		XA6SLX100	N/A	N/A	5.41	N/A	ns
		XQ6SLX75	N/A	N/A	4.77	7.15	ns
		XQ6SLX75T	4.32	N/A	4.77	N/A	ns
		XQ6SLX150	N/A	N/A	4.60	6.94	ns
		XQ6SLX150T	4.35	N/A	4.60	N/A	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. PLL output jitter is included in the timing calculation.

Table 71: Global Clock Setup and Hold Without DCM or PLL (Default Delay)

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
T <sub>PSFD</sub> / T <sub>PHFD</sub>	Default Delay <sup>(2)</sup> Global Clock and IFF <sup>(3)</sup> without DCM or PLL	XC6SLX4	0.66/1.17	N/A	1.05/0.79	2.09/1.05	ns
		XC6SLX9	0.66/1.17	0.75/1.17	1.05/1.17	2.09/1.05	ns
		XC6SLX16	0.87/1.16	0.93/1.16	0.96/1.16	1.86/1.06	ns
		XC6SLX25	0.68/0.77	0.81/0.81	0.87/0.82	2.21/1.33	ns
		XC6SLX25T	0.68/0.77	0.81/0.81	0.87/0.82	N/A	ns
		XC6SLX45	0.40/1.05	0.42/1.17	0.64/1.20	1.61/1.67	ns
		XC6SLX45T	0.40/1.05	0.42/1.17	0.64/1.20	N/A	ns
		XC6SLX75	0.41/1.11	0.41/1.13	0.80/1.14	1.23/1.82	ns
		XC6SLX75T	0.41/1.11	0.41/1.13	0.80/1.14	N/A	ns
		XC6SLX100	0.39/1.12	0.39/1.23	0.39/1.28	1.13/1.94	ns
		XC6SLX100T	0.39/1.12	0.39/1.23	0.39/1.28	N/A	ns
		XC6SLX150	0.23/1.54	0.23/1.62	0.23/1.62	1.14/2.05	ns
		XC6SLX150T	0.23/1.54	0.23/1.62	0.23/1.62	N/A	ns
		XA6SLX4	0.73/1.18	N/A	1.05/0.80	N/A	ns
		XA6SLX9	0.73/1.18	N/A	1.05/0.80	N/A	ns
		XA6SLX16	0.90/1.20	N/A	0.96/0.75	N/A	ns
		XA6SLX25	0.70/0.81	N/A	0.87/0.91	N/A	ns
		XA6SLX25T	0.76/0.81	N/A	1.03/0.91	N/A	ns
		XA6SLX45	0.40/1.06	N/A	0.64/1.20	N/A	ns
		XA6SLX45T	0.40/1.06	N/A	0.64/1.20	N/A	ns
		XA6SLX75	0.41/1.24	N/A	0.80/1.18	N/A	ns
		XA6SLX75T	0.41/1.24	N/A	0.80/1.18	N/A	ns
		XA6SLX100	N/A	N/A	0.86/1.55	N/A	ns
		XQ6SLX75	N/A	N/A	0.80/1.18	1.23/1.82	ns
		XQ6SLX75T	0.41/1.24	N/A	0.80/1.18	N/A	ns
		XQ6SLX150	N/A	N/A	0.28/1.57	1.14/2.05	ns
		XQ6SLX150T	0.28/1.78	N/A	0.28/1.57	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. Default delay uses IODELAY2 tap 0.
3. IFF = Input Flip-Flop or Latch.

Table 81: Source-Synchronous Pin-to-Pin Setup/Hold and Clock-to-Out Using BUFI02 (Cont'd)

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Pin-to-Pin Clock-to-Out Using BUFI02</b>							
TICKOFCs	OFF clock-to-out using BUFI02 clock	XC6SLX4	5.51	N/A	6.95	8.45	ns
		XC6SLX9	5.51	5.89	6.95	8.45	ns
		XC6SLX16	5.31	5.70	6.67	8.21	ns
		XC6SLX25	5.53	6.00	7.02	8.72	ns
		XC6SLX25T	5.53	6.00	7.02	N/A	ns
		XC6SLX45	5.76	6.18	7.22	8.77	ns
		XC6SLX45T	5.76	6.18	7.22	N/A	ns
		XC6SLX75	5.94	6.46	7.57	9.72	ns
		XC6SLX75T	5.94	6.46	7.57	N/A	ns
		XC6SLX100	6.09	6.53	7.60	9.66	ns
		XC6SLX100T	6.09	6.53	7.60	N/A	ns
		XC6SLX150	6.29	6.69	7.81	9.94	ns
		XC6SLX150T	6.29	6.69	7.81	N/A	ns
		XA6SLX4	5.83	N/A	6.95	N/A	ns
		XA6SLX9	5.83	N/A	6.95	N/A	ns
		XA6SLX16	5.65	N/A	6.68	N/A	ns
		XA6SLX25	5.85	N/A	7.03	N/A	ns
		XA6SLX25T	5.85	N/A	7.03	N/A	ns
		XA6SLX45	6.07	N/A	7.25	N/A	ns
		XA6SLX45T	6.07	N/A	7.25	N/A	ns
		XA6SLX75	6.26	N/A	7.57	N/A	ns
		XA6SLX75T	6.26	N/A	7.57	N/A	ns
		XA6SLX100	N/A	N/A	7.48	N/A	ns
		XQ6SLX75	N/A	N/A	7.57	9.72	ns
		XQ6SLX75T	6.26	N/A	7.57	N/A	ns
		XQ6SLX150	N/A	N/A	7.81	9.94	ns
		XQ6SLX150T	6.62	N/A	7.81	N/A	ns

Date	Version	Description of Revisions
06/14/10	1.5	<p>In <a href="#">Table 2</a>, added note 5 and added temperature range to <math>V_{FS}</math> and <math>R_{FUSE}</math>. Removed speed grade delineation, revised <math>I_{RPD}</math> description, and updated note 2 in <a href="#">Table 4</a>. Added note 2 to <a href="#">Table 7</a>. Added DIFF_MOBILE_DDR to <a href="#">Table 8</a> and <a href="#">Table 10</a>. Added note 4 to <a href="#">Table 15</a>. Changed minimum <math>DV_{PPIN}</math> in <a href="#">Table 16</a>. Updated <math>F_{GTPDRPCLK}</math> in <a href="#">Table 19</a>. Increased maximum <math>T_{LLSKEW}</math> in <a href="#">Table 22</a>. Updated descriptions and added data to <a href="#">Table 23</a>. Removed note 1 and added new data to the Networking Applications section in <a href="#">Table 25</a>. Updated <a href="#">Table 26</a> and <a href="#">Table 27</a> to the data in ISE v12.1 software with speed specification v1.08. In <a href="#">Table 28</a>, added DIFF_MOBILE_DDR and updated -4 speed grade data. Updated the maximum I/O pairs per bank in <a href="#">Table 33</a>. Updated note 2 on <a href="#">Table 39</a>. Revised the <math>F_{MAX}</math> in <a href="#">Table 44</a>. In <a href="#">Table 47</a>, updated description for <math>T_{SMCKCSO}</math>, revised values for <math>T_{POR}</math> and added Min value, added <math>T_{BPICCK}</math> and <math>T_{SPIICCK}</math>. Also in <a href="#">Table 47</a>, added device dependencies to <math>F_{SMCCK}</math> and <math>F_{RBCCCK}</math>. Updated and added data to <a href="#">Table 63</a> through <a href="#">Table 78</a>, and <a href="#">Table 81</a>. In <a href="#">Table 79</a>, added data on the XC6SLX45-FG(G)676 and revised the XC6SLX45T and XC6SLX150T values.</p> <p>The following changes to this specification are addressed in the product change notice <a href="#">XCN10024</a>, <i>MCB Performance and JTAG Revision Code for Spartan-6 LX16 and LX45 FPGAs</i>.</p> <p>In <a href="#">Table 2</a>, revised the <math>V_{CCINT}</math> to add the memory controller block extended performance specifications. In <a href="#">Table 25</a>, changed the standard specifications and added extended performance specifications for the memory controller block and note 2. Added note 4 and updated values in <a href="#">Table 34</a>.</p>
06/24/10	1.6	<p>Production release of XC6SLX45T (-2 and -3 speed grades), XC6SLX16 and XC6SLX45 (-3 speed grade) devices which includes changes to <a href="#">Table 26</a> and <a href="#">Table 27</a> (ISE v12.1 software with speed specification v1.08).</p> <p>Added the -3N speed grade, which designates Spartan-6 devices that do not support MCB functionality. This includes changes to <a href="#">Table 2</a> (note 2), <a href="#">Table 25</a> (note 4), and <a href="#">Switching Characteristics (Table 26)</a>.</p> <p>Updated <a href="#">Simultaneously Switching Outputs</a> discussion. Added -3 speed grade values for <math>T_{TAP}</math> and <math>F_{MINCAL}</math> values in <a href="#">Table 39</a>. In <a href="#">Table 40</a>, updated <math>T_{RPW}</math> (-2 and -3 speed grade) values and <math>F_{TOG}</math> (-3 speed grade) values. In <a href="#">Table 48</a>, updated <math>T_{GIO}</math> (-2 and -3 speed grade) values. Updated -3 values in spread spectrum section of <a href="#">Table 57</a>.</p>
07/16/10	1.7	<p>Production release of specific devices listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.2 software with speed specification v1.11. Added note 4 advising designers of the patch which contains v1.11. Also updated the -1L speed specification to v1.04. Updated numerous -4 and -1L values. Added -4 <math>T_{TAP}</math> values and <math>F_{MINCAL}</math> to <a href="#">Table 39</a>. Revised <math>T_{CINCK}/T_{CKCIN}</math> in <a href="#">Table 40</a>. In <a href="#">Table 41</a>, revised <math>T_{SHCKO}</math>. In <a href="#">Table 42</a>, revised <math>T_{REG}</math>. Added new -1L values to <a href="#">Table 47</a>. Added and updated values in <a href="#">Table 79</a>.</p>
07/26/10	1.8	<p>Production release of XC6SLX25, XC6SLX25T, XC6SLX100 and XC6SLX100T in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.2 software with speed specification v1.11. Added note 7 to <a href="#">Table 2</a> and moved <math>V_{FS}</math> and <math>R_{FUSE}</math> to a new <a href="#">Table 3</a>. Added <math>I_{HS}</math> and note 4 to <a href="#">Table 4</a>. Added note 1 to <a href="#">Table 28</a>. Added and updated SSO limits per <math>V_{CCO}/GND</math> pairs in <a href="#">Table 34</a>. Added note 3 to <a href="#">Table 47</a>. In <a href="#">Table 54</a>, removed -1L specifications for CLKOUT_PER_JITT_DV1/2 and revised CLKIN_CLKFB_PHASE and CLKOUT_PHASE_DLL values. Updated note 3 in both <a href="#">Table 56</a> and <a href="#">Table 57</a>.</p>
08/23/10	1.9	<p>Updated values for <math>F_{GTPRANGE1}</math>, <math>F_{GTPRANGE2}</math>, and <math>F_{GPLLMIN}</math> in <a href="#">Table 18</a>. Revised -3 and -4 values in <a href="#">Table 21</a>. Removed the -1L speed grade readback support restriction and note 3 in <a href="#">Table 47</a>.</p>
11/05/10	1.10	<p>Production release of XC6SLX4 and XC6SLX9 in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.3 software with speed specification v1.12 for the -2 speed grade available in the 12.3 Speed Files Patch. Added note 3 advising designers of the patch which contains v1.12.</p> <p>In <a href="#">Table 2</a>, added note 4. In <a href="#">Table 4</a>, added note 2. In <a href="#">Table 10</a>, added notes 2 and 3. In <a href="#">Table 44</a>, added note 2. In <a href="#">Table 47</a>, updated symbol for <math>T_{SMWCCK}/T_{SMCCW}</math>, changed -1L values for <math>T_{USERCCLKH}</math> and <math>T_{USERCCLKL}</math>, and added and revised the modes for <math>F_{MCCK}</math> and <math>F_{SMCCK}</math>. In <a href="#">Table 53</a>, redefined and expanded description for CLKIN_FREQ_DLL and rewrote note 3. Updated title of <a href="#">Table 58</a>. Also in <a href="#">Table 78</a>, revised <math>T_{DCD\_CLK}</math> for XC6SLX150 and XC6SLX150T. Changed description of <math>T_{PSFD}/T_{PHFD}</math> in <a href="#">Table 71</a>.</p> <p>For the -1L speed grade, updated data sheet to ISE 12.3 software with speed specification v1.05 which revised the values in the following tables: <a href="#">Table 25</a>, <a href="#">Table 28</a>, <a href="#">Table 35</a>, <a href="#">Table 36</a>, <a href="#">Table 37</a>, <a href="#">Table 40</a> through <a href="#">Table 43</a>, <a href="#">Table 48</a> through <a href="#">Table 56</a>, <a href="#">Table 62</a> through <a href="#">Table 78</a>, <a href="#">Table 80</a>, and <a href="#">Table 81</a>.</p> <p>Updated <a href="#">Notice of Disclaimer</a>.</p>

Date	Version	Description of Revisions
09/14/11	2.4	<p>Production release of the XA6SLX4 and XA6SLX9 devices in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -2 and -3 speed specification v1.19. Added production released version of the XA6SLX100 to <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.3 software with -2 speed specification v1.20.</p> <p>Updated <math>R_{OUT\_TERM}</math> description in <a href="#">Table 4</a>. Fixed the LVPECL <math>V_H</math> error in <a href="#">Table 31</a>. Updated introduction in <a href="#">Simultaneously Switching Outputs</a>. Added the XA6SLX100 to <a href="#">Table 63</a> through <a href="#">Table 78</a>, and <a href="#">Table 81</a>. Added <a href="#">Note 4</a> to <a href="#">Table 78</a> because the <math>T_{CKSKEW}</math> for the XC6SLX100 is not the same as the <math>T_{CKSKEW}</math> for the XA6SLX100.</p> <p>Revised the revision history for version <a href="#">1.6</a> dated <a href="#">06/24/10</a>. Removed the parenthetical statement about the -3N speed grade: (specifications are identical to the -3 speed grade).</p>
10/17/11	3.0	<p>Changed the data sheet from Preliminary Product Specification to Product Specification.</p> <p>Updated the <a href="#">Switching Characteristics, page 19</a> speed specification version ISE v13.3 software to -2 and -3 speed specification v1.20 and -1L speed specification of v1.08. Also updated <a href="#">Note 1</a> in <a href="#">Table 27</a>.</p> <p>In <a href="#">Table 43, Block RAM Switching Characteristics</a>, the <math>F_{MAX}</math> value for the -2 speed grade has been changed from 260 MHz to 280 MHz.</p> <p>In <a href="#">Table 54, Switching Characteristics for the DLL</a>, a <a href="#">Note 6</a> was added and linked to CLKIN_CLKFB_PHASE.</p>

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